## Notice of References Cited Application/Control No. 10/710,850 Examiner Michael C. Zarroli Applicant(s)/Patent Under Reexamination WATANABE, HIDEO Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,296,505 b1	10-2001	Fukunaga et al.	439/268
*	В	US-2003/0194898	10-2003	Hachuda, Osamu	439/331
*	С	US-4,808,119	02-1989	Pfaff, Wayne K.	439/268
*	D	US-6,027,355	02-2000	Ikeya, Kiyokazu	439/268
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	. Q					
	R					
	S				·	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) .
	U	
	V	
	W	
	х	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.